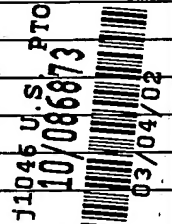
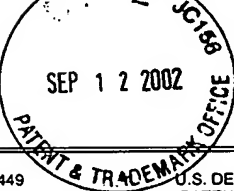


Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE		ATTY DOCKET NO. 220137US0		SERIAL NO. NEW APPLICATION	
LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Katsuhisa INOUE, et al.			
				FILING DATE HEREWITH		GROUP	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	AA	DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	4,639,468	01/27/87	Romeo RONCUCCI, et al.			
	AB						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
	AO	5-271035	10/19/93	JAPAN (English Abstract Only)			
	AP	5-271036	10/19/93	JAPAN (English Abstract Only)			
	AQ	2000-501430	02/08/02	JAPAN (with English Abstract, Corresponds to WO 98/40046)			X
	AR	WO98/40046	09/17/98	WIPO			
	AS	55-143944	11/10/80	JAPAN (with English Abstract, Corresponds to US 4,639,468)			X
	AT	WO98/03472	01/29/98	WIPO			
	AU	9-118606	05/06/97	JAPAN (English Abstract Only)			
	AV	2000-302651	10/31/00	JAPAN (with English Abstract)			X
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner					Date Considered		
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.							





SHEET 1 OF 1

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APPLICANT

Katsuhisa INOUE, et al.

FILING DATE

March 4, 2002

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1619

## LIST OF REFERENCES CITED BY APPLICANT

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA	4,639,668	01/27/87	P. PETIT, et al.			
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## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AO	1 165 038	03/12/64	GERMANY		X
	AP	WO 98/40046	09/17/98	WIPO		
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

Examiner

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PATENT AND TRADEMARK OFFICEATTY DOCKET NO.  
220137US0SERIAL NO.  
10/086,873

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT  
Katsuhisa INOUE, et al.FILING DATE  
March 4, 2002GROUP  
1619

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
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## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AO	217 513	01/16/85	GERMANY (corr. US 4,639,468 was filed on March 4, 2002)		X
	AP					
	AQ					
	AR					
	AS					
	AT					
	AU					
	AV					

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